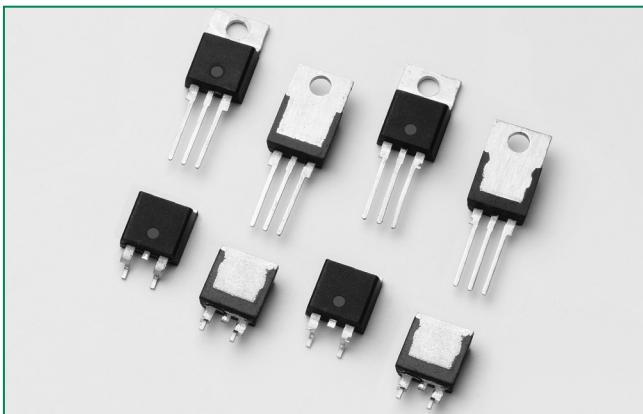


SJxx40x Series

Main Features

Symbol	Value	Unit
I_{TRMS}	40	A
V_{DRM}/V_{RRM}	400 or 600	V
I_{GT}	40	mA

Description

This SJxx40x high temperature SCR series is ideal for uni-directional switch applications such as phase control in heating, motor speed controls and AC rectifier and voltage regulator.

These SCRs have a low gate current trigger level of 40 mA maximum at approximately 1.5 V, with a sensitive version of this series having a gate trigger current of 15 mA maximum.

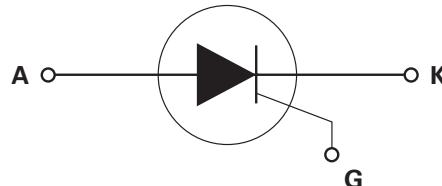
Features & Benefits

- High junction temperature
- Voltage capability up to 600 V
- Surge capability up to 520 A at 60 Hz half cycle
- Halogen free and RoHS compliant

Applications

Typical applications are AC rectifier, voltage regulator, AC solid-state switches, industrial power tools, exercise equipment, white goods and commercial appliances.

Schematic Symbol



Absolute Maximum Ratings

Symbol	Parameter	Test Conditions	Value	Unit
V_{DSM}/V_{RSM}	Peak non-repetitive blocking voltage	$P_w = 100\mu s$	700	V
I_{TRMS}	RMS on-state current	$T_c = 120^\circ C$	40	A
$I_{T(AV)}$	Average on-state current	$T_c = 120^\circ C$	25.0	A
I_{TSM}	Peak non-repetitive surge current	single half cycle; $f = 50Hz$; T_j (initial) = $25^\circ C$	430	A
		single half cycle; $f = 60Hz$; T_j (initial) = $25^\circ C$	520	
I^2t	I^2t Value for fusing	$t_p = 8.3 ms$	1122	A^2s
di/dt	Critical rate of rise of on-state current	$f = 60Hz ; T_j = 150^\circ C$	150	$A/\mu s$
I_{GM}	Peak gate current	$t_p \leq 10\mu s ; T_j = 150^\circ C$	4	A
$P_{G(AV)}$	Average gate power dissipation	$t_p \leq 10\mu s ; T_j = 150^\circ C$	1	W
T_{stg}	Storage temperature range		-40 to 150	$^\circ C$
T_j	Operating junction temperature range		-40 to 150	$^\circ C$

Electrical Characteristics ($T_J = 25^\circ\text{C}$, unless otherwise specified)

Symbol	Test Conditions		SJxx40x	SJxx40x2	Unit
I_{GT}	$V_D = 12\text{V}; R_L = 30 \Omega$	MAX.	40	15	mA
		MIN.	5	3	
V_{GT}			MAX. 1.5		V
dv/dt	$V_D = V_{DRM}$; gate open; $T_J = 125^\circ\text{C}$	400V	650	400	V/ μs
		600V			
	$V_D = V_{DRM}$; gate open; $T_J = 150^\circ\text{C}$	400V	550	300	
		600V	500	250	
V_{GD}	$V_D = V_{DRM}; R_L = 3.3 \text{k}\Omega; T_J = 150^\circ\text{C}$	MIN.	0.2		V
I_H	$I_T = 400\text{mA}$ (initial)	MAX.	60	50	mA
t_q	$I_T=2\text{A}; t_p=50\mu\text{s}; dv/dt=5\text{V}/\mu\text{s}; di/dt=-30\text{A}/\mu\text{s}$	MAX.	35		μs
t_{gt}	$I_G = 2 \times I_{GT}; PW = 15\mu\text{s}; I_T = 80\text{A}$	TYP.	2		μs

NOTE: xx = voltage, x = package

Static Characteristics

Symbol	Test Conditions		Value	Unit
V_{TM}	$I_T = 80\text{A}; t_p = 380\mu\text{s}$	MAX.	1.7	V
I_{DRM} / I_{RRM}	@ V_{DRM} / V_{RRM}	$T_J = 25^\circ\text{C}$	10	μA
		$T_J = 125^\circ\text{C}$	2000	
		$T_J = 150^\circ\text{C}$	4000	

Thermal Resistances

Symbol	Parameter		Value	Unit
$R_{\theta(J-C)}$	Junction to case (AC)	SJxx40Ry/SJxx40Ny	0.8	$^\circ\text{C}/\text{W}$
$R_{\theta(J-A)}$	Junction to ambient	Sxx40Ry	40	$^\circ\text{C}/\text{W}$

Note: xx = voltage, y = sensitivity & type

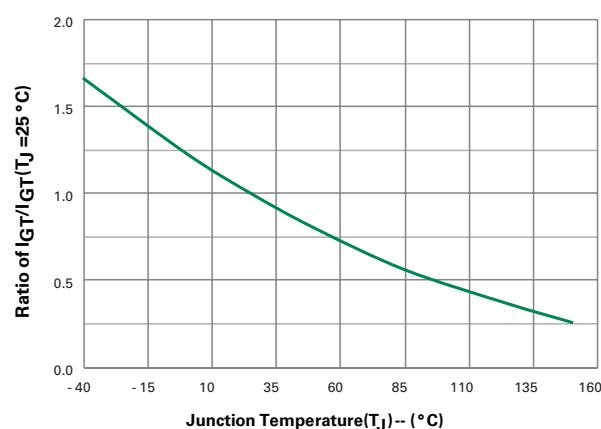
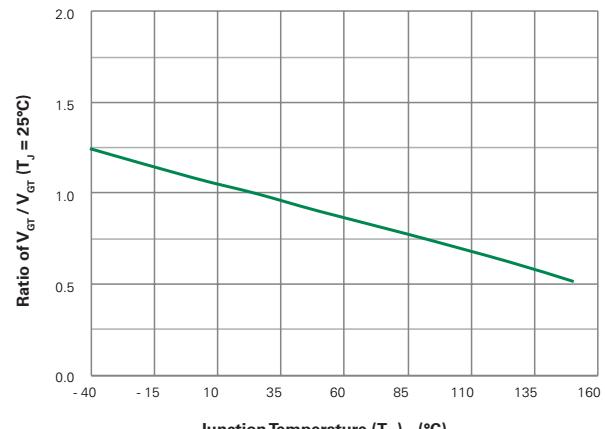
Figure 1: Normalized DC Gate Trigger Current vs. Junction Temperature

Figure 2: Normalized DC Gate Trigger Voltage vs. Junction Temperature


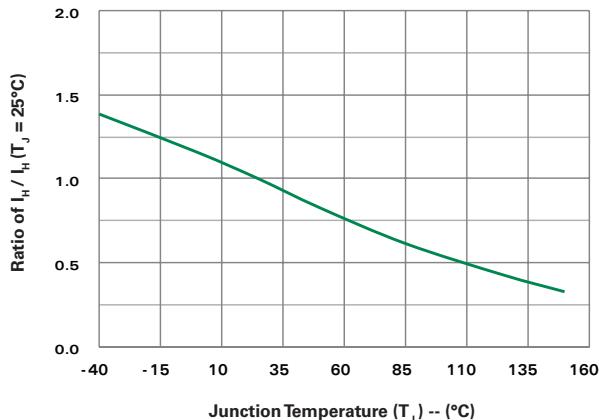
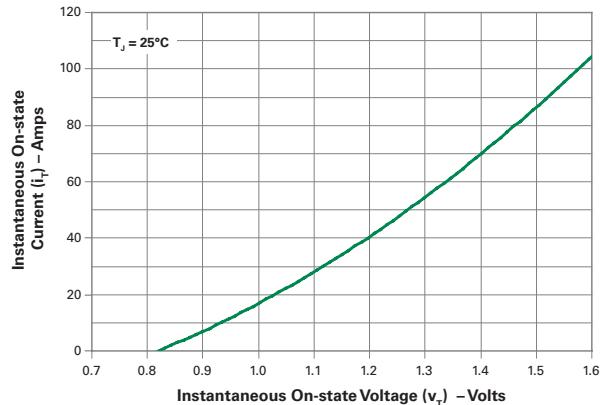
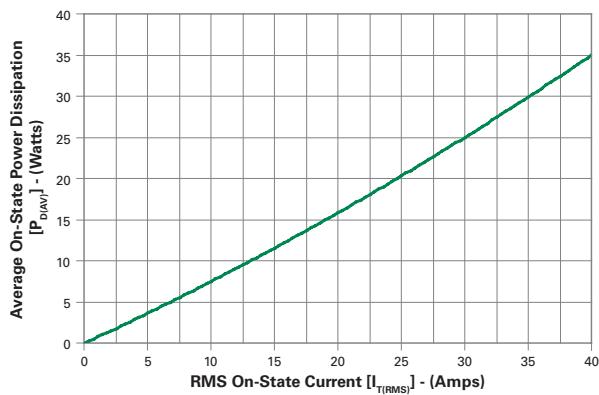
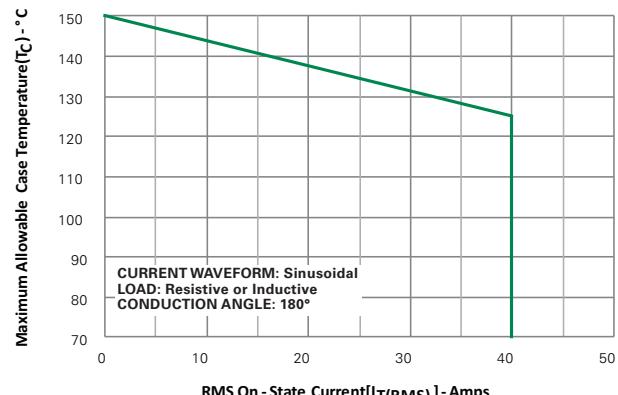
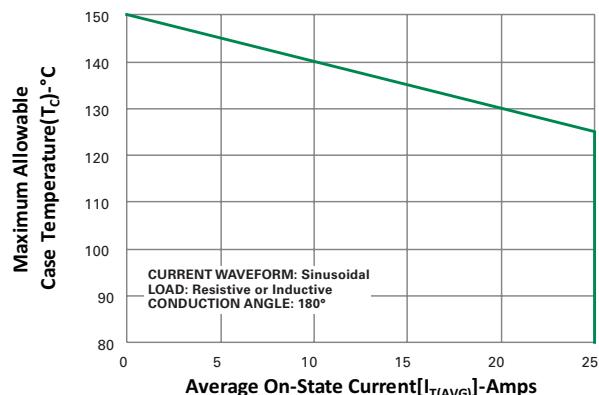
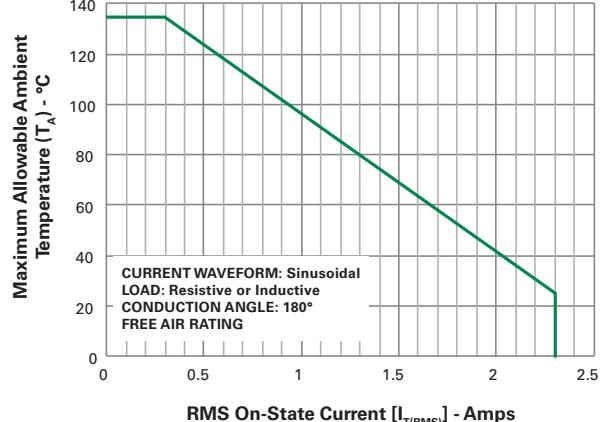
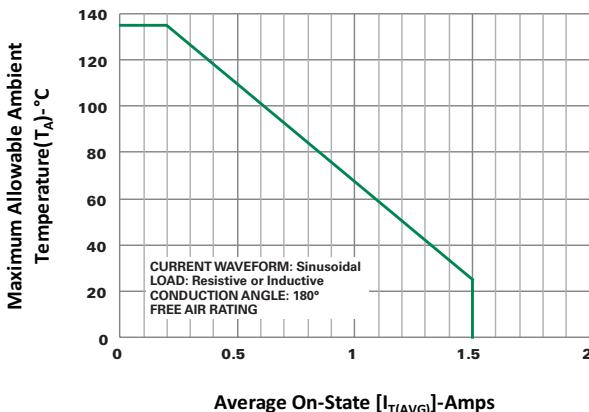
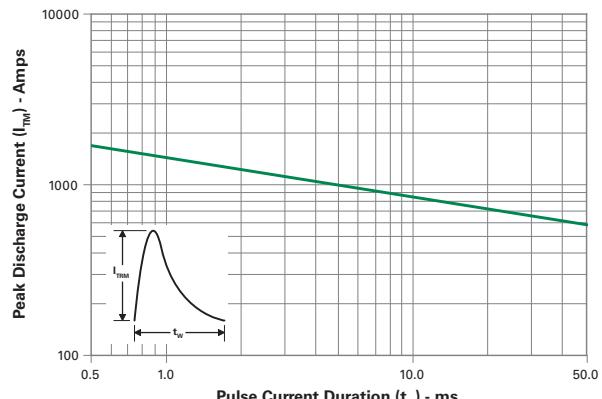
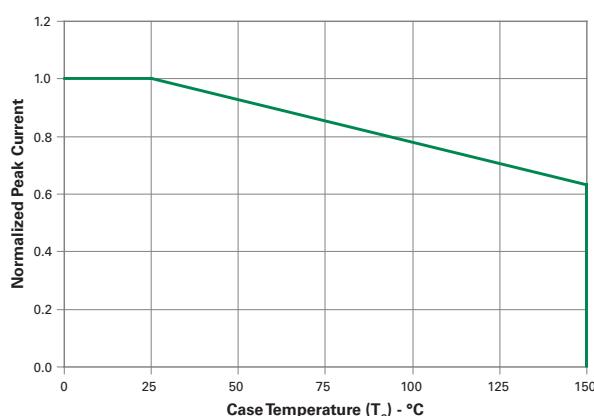
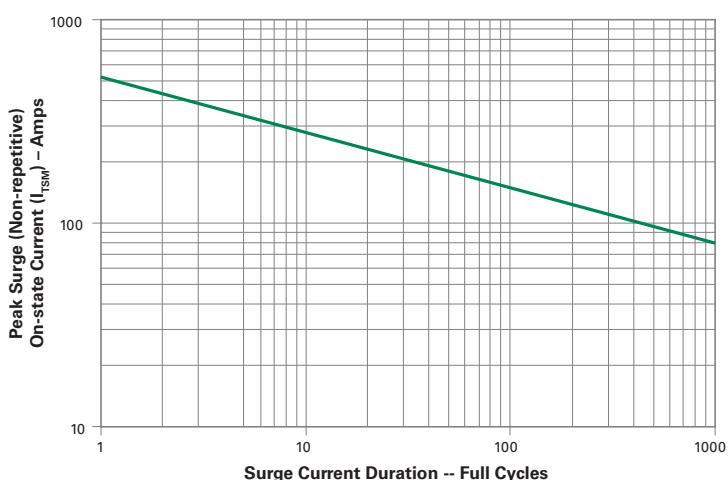
Figure 3: Normalized DC Holding Current vs. Junction Temperature

Figure 4: On-State Current vs. On-State Voltage (Typical)

Figure 5: Power Dissipation (Typical) vs. RMS On-State Current

Figure 6: Maximum Allowable Case Temperature vs. RMS On-State Current

Figure 7: Maximum Allowable Case Temperature vs. Average On-State Current

Figure 8: Maximum Allowable Ambient Temperature vs. RMS On-State Current


Figure 9: Maximum Allowable Ambient Temperature vs. Average On-State Current

Figure 10: Peak Capacitor Discharge Current

Figure 11: Peak Capacitor Discharge Current Derating

Figure 12: Surge Peak On-State Current vs. Number of Cycles


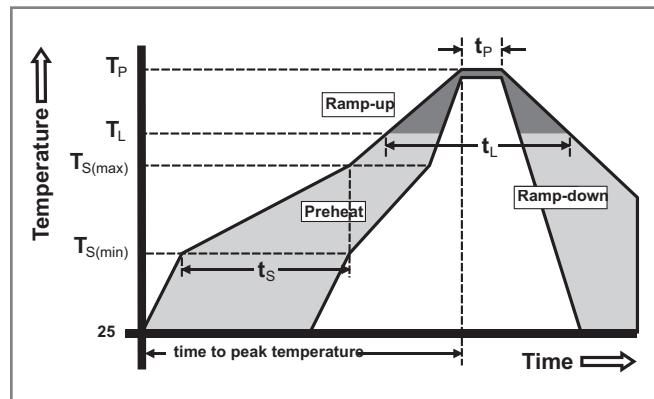
SUPPLY FREQUENCY: 60 Hz Sinusoidal
LOAD: Resistive
RMS On-State Current: [$I_{(RMS)}$]: Maximum Rated Value at Specified Case Temperature

Notes:

1. Gate control may be lost during and immediately following surge current interval.
2. Overload may not be repeated until junction temperature has returned to steady-state rated value.

Soldering Parameters

Reflow Condition		Pb – Free assembly
Pre Heat	-Temperature Min ($T_{s(min)}$)	150°C
	-Temperature Max ($T_{s(max)}$)	200°C
	-Time (min to max) (t_s)	60 – 180 secs
Average ramp up rate (Liquidus Temp) (T_L) to peak		5°C/second max
$T_{S(max)}$ to T_L - Ramp-up Rate		5°C/second max
Reflow	-Temperature (T_L) (Liquidus)	217°C
	-Time (t_L)	60 – 150 seconds
Peak Temperature (T_p)		260 ^{+0/-5} °C
Time within 5°C of actual peak Temperature (t_p)		20 – 40 seconds
Ramp-down Rate		5°C/second max
Time 25°C to peak Temperature (T_p)		8 minutes Max.
Do not exceed		280°C



Physical Specifications

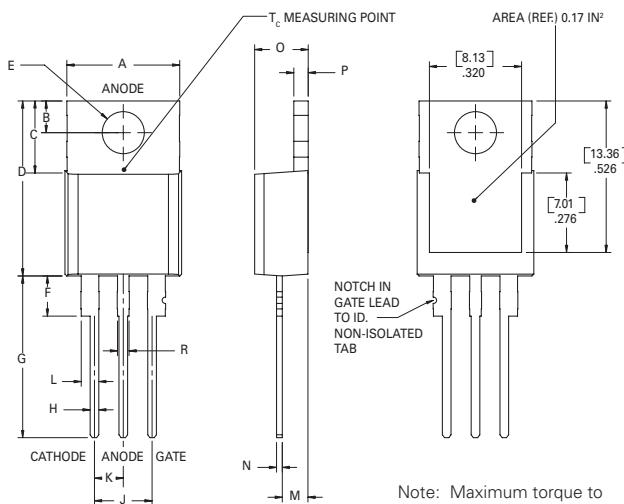
Terminal Finish	100% Matte Tin-plated
Body Material	UL Recognized epoxy meeting flammability rating V-0
Lead Material	Copper Alloy

Design Considerations

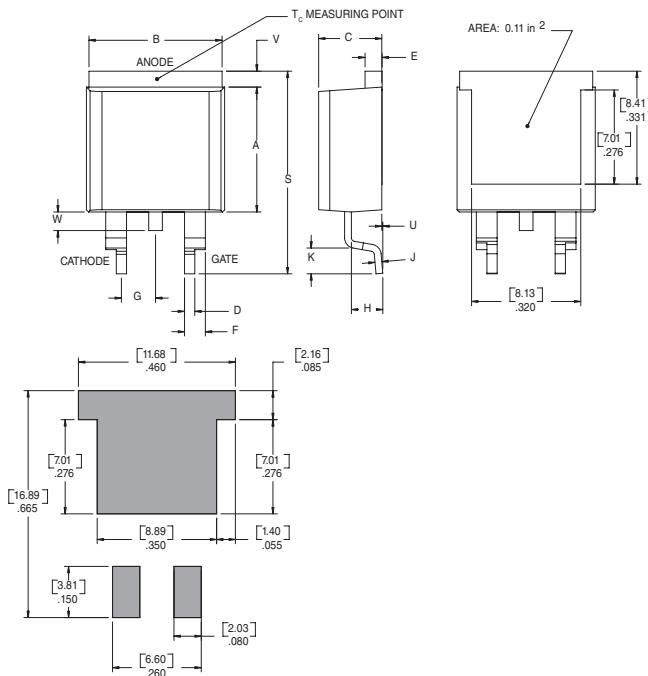
Careful selection of the correct component for the application's operating parameters and environment will go a long way toward extending the operating life of the Thyristor. Good design practice should limit the maximum continuous current through the main terminals to 75% of the component rating. Other ways to ensure long life for a power discrete semiconductor are proper heat sinking and selection of voltage ratings for worst case conditions. Overheating, overvoltage (including dv/dt), and surge currents are the main killers of semiconductors. Correct mounting, soldering, and forming of the leads also help protect against component damage.

Environmental Specifications

Test	Specifications and Conditions
AC Blocking	MIL-STD-750, M-1040, Cond A Applied Peak AC voltage @ 150°C for 1008 hours
Temperature Cycling	MIL-STD-750, M-1051, 100 cycles; -40°C to +150°C; 15-min dwell-time
Temperature/ Humidity	EIA / JEDEC, JESD22-A101 1008 hours; 320V - DC: 85°C; 85% rel humidity
High Temp Storage	MIL-STD-750, M-1031, 1008 hours; 150°C
Low-Temp Storage	1008 hours; -40°C
Resistance to Solder Heat	MIL-STD-750 Method 2031
Solderability	ANSI/J-STD-002, category 3, Test A
Lead Bend	MIL-STD-750, M-2036 Cond E
Moisture Sensitivity Level	Level 1, JEDEC-J-STD-020D

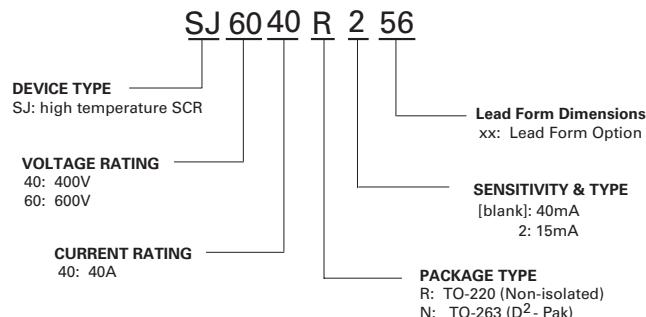
Dimensions – TO-220AB (R-Package) – Non-Isolated Mounting Tab Common with Center Lead


Dimension	Inches		Millimeters	
	Min	Max	Min	Max
A	0.380	0.420	9.65	10.67
B	0.105	0.115	2.67	2.92
C	0.230	0.250	5.84	6.35
D	0.590	0.620	14.99	15.75
E	0.142	0.147	3.61	3.73
F	0.110	0.130	2.79	3.30
G	0.540	0.575	13.72	14.61
H	0.025	0.035	0.64	0.89
J	0.195	0.205	4.95	5.21
K	0.095	0.105	2.41	2.67
L	0.060	0.075	1.52	1.91
M	0.085	0.095	2.16	2.41
N	0.018	0.024	0.46	0.61
O	0.178	0.188	4.52	4.78
P	0.045	0.060	1.14	1.52
R	0.038	0.048	0.97	1.22

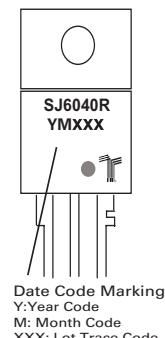
Dimensions – TO-263 (N-package) – D²-Pak Surface Mount


Dimension	Inches		Millimeters	
	Min	Max	Min	Max
A	0.360	0.370	9.14	9.40
B	0.380	0.420	9.65	10.67
C	0.178	0.188	4.52	4.78
D	0.025	0.035	0.63	0.89
E	0.048	0.055	1.22	1.40
F	0.060	0.075	1.52	1.91
G	0.095	0.105	2.41	2.67
H	0.083	0.093	2.11	2.36
J	0.018	0.024	0.46	0.61
K	0.090	0.110	2.29	2.79
S	0.590	0.625	14.99	15.87
V	0.035	0.045	0.89	1.14
U	0.002	0.010	0.05	0.25
W	0.040	0.070	1.02	1.78

Part Numbering System



Part Marking System



Product Selector

Part Number	Voltage		Gate Sensitivity	Type	Package
	400V	600V			
SJxx40R	X	X	40mA	Standard SCR	TO-220R
SJxx40N	X	X	40mA	Standard SCR	TO-263
SJxx40R2	X	X	15mA	Standard SCR	TO-220R
SJxx40N2	X	X	15mA	Standard SCR	TO-263

Note: xx = Voltage

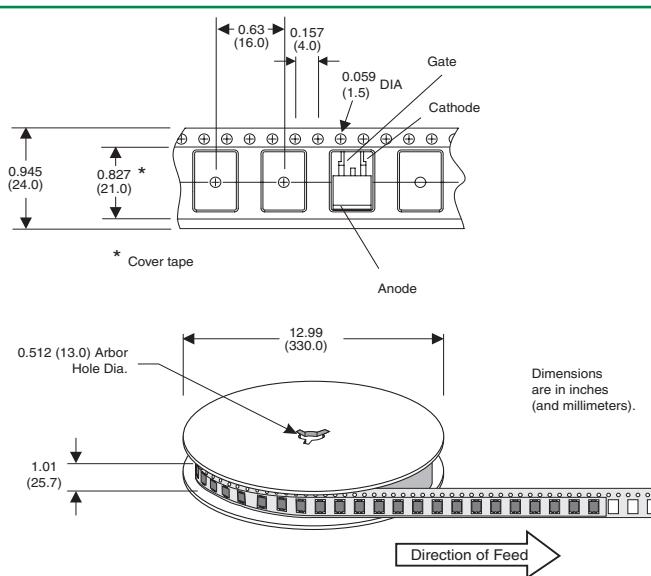
Packing Options

Part Number	Marking	Weight	Packing Mode	Base Quantity
SJxx40RTP	SJxx40R	2.2g	Tube	500 (50 per tube)
SJxx40NTP	SJxx40N	1.6g	Tube	500 (50 per tube)
SJxx40NRP	SJxx40N	1.6g	Embossed Carrier	500
SJxx40R2TP	SJxx40R2	2.2g	Tube	500 (50 per tube)
SJxx40N2RP	SJxx40N2	1.6g	Embossed Carrier	500

Note: xx = Voltage

Reel Pack (RP) for TO-263 Embossed Carrier Specifications

Meets all EIA-481-2 Standards



SJxx40x Series